

Wide-temperature SO-DIMM

DDR5 4800

Datasheet

Products

TS2GSA64V8E-I

Product Description

16GB DDR5 4800 SO-DIMM 1Rx8 IND 2Gx8 CL40 1.1V

Datasheet version

1.0

Revision History

Revision No.	History	Released Date	Editor by
1.0	First version	2023/07/14	PM

Transcend Features

Part Name	Capacity	Organization	Rank	Height	DIMM type	Note
TS2GSA64V8E-I	16GB	2Gx8	1	30.00mm	SO-DIMM	Anti-sulfur

FEATURES

- Operating Temperature : -40°C to +95°C
- RoHS compliant products.
- VDD = VDDQ = 1.1V (1.067V(- 3%) ~ 1.166V(+6%))
- VPP = 1.8V(1.746V(-3%) ~ 1.908V(+6%))
- Clock Freq: 2400MHz for 4800Mb/s/Pin.
- Programmable CAS Latency: 22,26,28,30,32,36,40,42
- 16n bit pre-fetch
- Burst Length: 16 by default
- 32 internal banks (x4, x8): 8 groups of 4 banks each
- Multi-purpose command (MPC)
- On-Die ECC
- SPD Hub with Thermal Sensor
- hPPR and sPPR are supported
- 30 u" PCB golden finger thickness
- Embedded Anti-sulfur resistor

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1. Introduction

1.1 General Feature Information

Hardware Feature

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- RoHS compliant products.
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- On-Die ECC
- SPD Hub with Thermal Sensor
- hPPR and sPPR are supported
- 30 u" PCB golden finger thickness
- Embedded Anti-sulfur resistor

1.2 Product List

DIMM Type	Part Name	Capacity
SO-DIMM	TS2GSA64V8E-I	16GB

1.3 Ordering Information

<u>T</u>	<u>S</u>	<u>2</u>	<u>G</u>	<u>S</u>	<u>A</u>	<u>6</u>	<u>4</u>	<u>V</u>	<u>8</u>	<u>E</u>	<u>-</u>	<u>I</u>
1	2	3	4	5	6	7	8					

1 – Transcend

2 – DRAM module capacity = 2GB x 8

3 – SO-DIMM

4 – Module memory bus width

5 – Operation voltage 1.1V

6 – 4800

7 – 2Gx8

8 – Wide-temperature operation from -40°C to +95°C

2. Product Specifications

2.1 Interface and Compliance

- DDR5 4800 wide-temperature SODIMM (Small Outline) with 64 Bits data width
- Non-ECC Unbuffered Memory
- RoHS Compliance
- CE and UKCA Compliance

2.2 Supply Voltage

[Table 1] Absolute Maximum DC Ratings

Parameter	Symbol	Value	Unit	Note
Voltage on VDD relative to Vss	VDD	-0.3 ~ 1.4	V	1)
Voltage on VDDQ pin relative to Vss	VDDQ	-0.3 ~ 1.4	V	1)
Voltage on VPP pin relative to Vss	VPP	-0.3 ~ 2.1	V	
Voltage on any pin relative to Vss	VIN, VOUT	-0.3 ~ 1.4	V	1)
Storage temperature	TSTG	-55~+100	°C	1), 2)

Note:

1. Stresses greater than those listed in this table may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. Storage temperature is the case surface temperature on the center/top side of the device. For the measurement conditions, refer to JESD51-2 standard.

[Table 2] Recommended AC & DC Operating Conditions

Parameter	Symbol	Rating			Unit	Note
		Min	Typ.	Max		
Device Supply Voltage	VDD	1.067(-3%)	1.1	1.166(+6%)	V	1), 2), 3)
Supply Voltage for I/O	VDDQ	1.067(-3%)	1.1	1.166(+6%)	V	1), 2), 3)
Core Power Voltage	VPP	1.746(-3%)	1.8	1.908(+6%)	V	3)

Note:

1. VDD must be within 66mV of VDDQ.
2. AC parameters are measured with VDD and VDDQ tied together.
3. This includes all voltage noise from DC to 2 MHz at the DRAM package ball

2.3 IDD Specification Parameters and Table

[Table 3] IDD Specification Parameters –16GB, 2G x 64 Module (1 Rank x 8)

Parameters	Symbol	IDD Max.	IDDQ Max.	IPP Max.	Unit
Operating One Bank Active-Precharge Current	/DD0	424	176	56	mA
Precharge Standby Current	/DD2N	240	168	32	mA
Precharge Power-Down Current	/DD2P	184	120	32	mA
Active Standby Current	/DD3N	368	168	40	mA
Active Power-Down Current	/DD3P	240	104	40	mA
Operating Burst Read Current	/DD4R	1520	1296	64	mA
Operating Burst Write Current	/DD4W	1840	1376	64	mA
Burst Refresh Current	/DD5B	1840	184	448	mA
Self Refresh Current	/DD6N	496	40	96	mA
Operating Bank Interleave Read Current	/DD7	2560	1296	240	mA

Note:

1. IDD values are for full operating range of Voltage and Temperature
2. Module IDD was calculated on the specific brand DRAM component IDD and can be differently measured according to DQ loading capacitor.

2.4 Timing Parameters and Specifications

[Table 4] Timing Parameters and Specifications

Speed		DDR5-4800		Units	NOTE
Parameter	Symbol	MIN	MAX		
Read command to first data	tAA	16	22.222	ns	
Activate to Read or Write command delay time	tRCD	16	-	ns	
Row Precharge Time	tRP	16	-	ns	
Activate to Precharge command period	tRAS	32	5x tREFI	ns	
Activate to Activate or Refresh command period	tRC	48	-	ns	
Clock Timing					
Average Clock Period	tCK(avg)	0.416	<0.454	ns	
Command and Address Timing					
CAS_n to CAS_n command delay for same bank group	tCCD_L	max(8nCK, 5ns)		nCK	
WRITE CAS_n to WRITE CAS_n command delay for same bank group	tCCD_L_WR	max(32nCK, 20ns)		ns	
WRITE CAS_n to WRITE CAS_n command delay for same bank group, second write not RMW	tCCD_L_WR2	Max(16nCK, 10ns)		nCK	
CAS_n to CAS_n command delay for different bank group	tCCD_S	8	-	nCK	
ACTIVATE to ACTIVATE Command delay to different bank group for 2KB page size	tRRD_S(2K)	8	-	nCK	
ACTIVATE to ACTIVATE Command delay to different bank group for 2KB page size	tRRD_S(1K)	8	-	nCK	
ACTIVATE to ACTIVATE Command delay to same bank group for 2KB page size	tRRD_L(2K)	max(8nCK, 5ns)		nCK	
ACTIVATE to ACTIVATE Command delay to same bank group for 1KB page size	tRRD_L(1K)	max(8nCK, 5ns)		nCK	
Four activate window for 2KB page size	tFAW_2K	Max(40nCK, 16.640ns)		ns	
Four activate window for 1KB page size	tFAW_1K	Max(32nCK, 13.312ns)		ns	
Delay from start of internal write transaction to internal read command for different bank group	tWTR_S	Max(4nCK, 2.5ns)		ns	
Delay from start of internal write transaction to internal read command for same bank group	tWTR_L	Max(16nCK, 10ns)		ns	
Delay from start of internal write transaction to internal read with auto pre-charge command for same bank	tWTRA	tWR-tRTP		ns	
Internal READ Command to PRE-CHARGE Command delay	tRTP	Max(12nCK, 7.5ns)		ns	
PRECHARGE (PRE) to PRECHARGE(PRE) delay	tPPD	2		nCK(avg)	
WRITE recovery time	tWR	29.952	-	ns	

2.5 Serial Presence Detect Specification

[Table 5] Serial Presence Detect Specification

TS2GSA64V8E-I Serial Presence Detect		
Byte No.	Description	Hex Value
0	Number of Bytes in SPD Device	30
1	SPD Revision	10
2	Host Bus Command Protocol Type	12
3	Module Type	03
4	First SDRAM Density and Package	04
5	First SDRAM Addressing	00
6	First SDRAM I/O Width	20
7	First SDRAM Bank Groups & Banks Per Bank Group	62
8	Second SDRAM Density and Package	00
9	Second SDRAM Addressing	00
10	Secondary SDRAM I/O Width	00
11	Second SDRAM Bank Groups & Banks Per Bank Group	00
12	SDRAM BL32 & Post Package Repair	90
13	SDRAM Duty Cycle Adjuster & Partial Array Self Refresh	02
14	SDRAM Fault Handling and Temperature Sense	00
15	Reserved	00
16	SDRAM Nominal Voltage, VDD	00
17	SDRAM Nominal Voltage, VDDQ	00
18	SDRAM Nominal Voltage, VPP	00

19	SDRAM Timing	00
20	SDRAM Minimum Cycle Time(LSB)	A0
21	SDRAM Minimum Cycle Time(MSB)	01
22	SDRAM Maximum Cycle Time(LSB)	F2
23	SDRAM Maximum Cycle Time(MSB)	03
24	SDRAM CAS Latencies Supported	7A
25		0D
26		00
27		00
28		00
29	Reserved	00
30-31	SDRAM Minimum CAS Latency Time (tAamin)	80
		3E
32-33	SDRAM Minimum RAS to CAS Delay Time (tRCDmin)	80
		3E
34-35	SDRAM Minimum Row Precharge Delay Time (tRPmin)	80
		3E
36-37	SDRAM Minimum Active to Precharge Delay Time (tRASmin)	00
		7D
38-39	SDRAM Minimum Active to Active/Refresh Delay Time (tRCmin)	80
		BB
40-41	SDRAM Minimum Write Recovery Time (tWRmin)	30
		75
42-43	SDRAM Minimum Refresh Recovery Delay Time (tRFC1min)	27
		01
44-45	SDRAM Minimum Refresh Recovery Delay Time (tRFC2min)	A0
		00
46-47	SDRAM Minimum Refresh Recovery Delay Time (tRFCsbmin)	82
		00
48-49	SDRAM Minimum Refresh Recovery Delay Time,3DS Different Logical Rank (tRFC1min)	00
		00
50-51	SDRAM Minimum Refresh Recovery Delay Time,3DS Different Logical Rank (tRFC2min)	00
		00
52-53	SDRAM Minimum Refresh Recovery Delay Time,3DS Different Logical Rank (tRFCsbmin)	00
		00
54	SDRAM Refresh Management, First Byte, FirstSDRAM 1	00
55	SDRAM Refresh Management, Second Byte, FirstSDRAM 1	00

56	SDRAM Refresh Management, First Byte, Second SDRAM 1	00
57	SDRAM Refresh Management, Second Byte, Second SDRAM 1	00
58	SDRAM Adaptive Refresh Management Level A, First Byte, First SDRAM 1	00
59	SDRAM Adaptive Refresh Management Level A, Second Byte, First SDRAM 1	00
60	SDRAM Adaptive Refresh Management Level A, First Byte, Second SDRAM 1	00
61	SDRAM Adaptive Refresh Management Level A, Second Byte, Second SDRAM 1	00
62	SDRAM Adaptive Refresh Management Level B, First Byte, First SDRAM 1	00
63	SDRAM Adaptive Refresh Management Level B, Second Byte, First SDRAM 1	00
64	SDRAM Adaptive Refresh Management Level B, First Byte, Second SDRAM 1	00
65	SDRAM Adaptive Refresh Management Level B, Second Byte, Second SDRAM 1	00
66	SDRAM Adaptive Refresh Management Level C, First Byte, First SDRAM 1	00
67	SDRAM Adaptive Refresh Management Level C, Second Byte, First SDRAM 1	00
68	SDRAM Adaptive Refresh Management Level C, First Byte, Second SDRAM 1	00
69	SDRAM Adaptive Refresh Management Level C, Second Byte, Second SDRAM 1	00
70	SDRAM Minimum Active to Active Command Delay Time, Same Bank Group (tRRD_Lmin)	88
71		13
72		08
73	SDRAM Minimum Read to Read Command Delay Time, Same Bank Group (tCCD_Lmin)	88
74		13
75		08
76	SDRAM Minimum Write to Write Command Delay Time, Same Bank Group (tCCD_L_WRmin)	20
77		4E
78		20
79	SDRAM Minimum Write to Write Command Delay Time, Second Write not RMW, Same Bank Group (tCCD_L_WR2min)	10
80		27
81		10
82	SDRAM Minimum Four Activate Window (tFAWmin)	15
83		34
84		20
85	SDRAM Minimum Write to Read Command Delay Time,	10

86	Same Bank Group (tCCD_L_WTRmin)	27
87		10
88	SDRAM Minimum Write to Read Command Delay Time, Different Bank Group(tCCD_S_WTRmin)	C4
89		09
90		04
91	SDRAM Minimum Read to Precharge Command Delay Time, (tRTPmin)	4C
92		1D
93		0C
94-127	Base Configuration Section	00
128-191	Reserved for future use	00
192	SPD Revision for SPD bytes 192~447	10
193	Hashing Sequence	00
194	SPD Manufacturer ID Code, First Byte	Variable
195	SPD Manufacturer ID Code, Second Byte	Variable
196	SPD Device Type	Variable
197	SPD Device Revision Number	Variable
198	PMIC 0 Manufacturer ID Code, First Byte	Variable
199	PMIC 0 Manufacturer ID Code, Second Byte	Variable
200	PMIC 0 Device Type	Variable
201	PMIC 0 Revision Number	Variable
202	PMIC 1 Manufacturer ID Code, First Byte	Variable
203	PMIC 1 Manufacturer ID Code, Second Byte	Variable
204	PMIC 1 Device Type	Variable
205	PMIC 1 Revision Number	Variable
206	PMIC 2 Manufacturer ID Code, First Byte	Variable
207	PMIC 2 Manufacturer ID Code, Second Byte	Variable
208	PMIC 2 Device Type	Variable
209	PMIC 2 Revision Number	Variable
210	Thermal Sensor Manufacturer ID Code, First Byte	Variable
211	Thermal Sensor Manufacturer ID Code, Second Byte	Variable
212	Thermal Sensor Device Type	Variable
213	Thermal Sensor Revision Number	Variable
214-229	Reserved	00
230	Module Nominal Height	0F
231	Module Maximum Thickness	01
232	Reference Raw Card Used	00
233	DIMM Attributes	32
234	Module Organization	00
235	Memory Channel Bus Width	22

236-239	Reserved	00
240-447	Reserved	00
448-509	Reserved for future use	00
510-511	CRC for bytes 0-509	Variable
512	Module Manufacturer's ID Code	01
513		4F
514	Module Manufacturing Location	54
515	Module Manufacturing Date	Variable
516		Variable
517-520	Module Serial Number	Variable
521-550	Module Part Number	Note 1
551	Module Revision Code	00
552	DRAM Manufacturer ID Code	Variable
553		Variable
554	DRAM Stepping	Variable
555-639	Manufacturer's Specific Data	Variable
640-1023	End User Programmable	Variable

Note:

- The detail Model Part Number is listed as below.

Byte	521	522	523	524	525	526	527	528	529	530	531	532	533	534
PN	T	S	2	G	S	A	6	4	V	8	E	-	I	
Hex	54	53	32	47	53	41	36	34	56	38	45	2D	49	20

Byte	535	536	537	538	539	540	541	542	543	544	545	546	547	548
PN														
Hex	20	20	20	20	20	20	20	20	20	20	20	20	20	20

Byte	549	550
PN		
Hex	20	20

2.6 Hub Device Address

[Table 6] Hub Device Address

	Local Device Type ID (LID)					Host ID (HID)	HSA Pin connection
	PMIC	SPD Hub	RCD	TS0	TS1		
DIMM 0	1001	1010	1011	0010	0110	000	10.0 K Ω to GND
DIMM 1	1001	1010	1011	0010	0110	001	15.4 K Ω to GND
DIMM 2	1001	1010	1011	0010	0110	010	23.2 K Ω to GND
DIMM 3	1001	1010	1011	0010	0110	011	35.7 K Ω to GND
DIMM 4	1001	1010	1011	0010	0110	100	54.9 K Ω to GND
DIMM 5	1001	1010	1011	0010	0110	101	84.5 K Ω to GND
DIMM 6	1001	1010	1011	0010	0110	110	127 K Ω to GND
DIMM 7	1001	1010	1011	0010	0110	111	196 K Ω to GND

Note:

- RCD/TS0/TS1 is not used on Unbufferd DIMM

2.7 SPD HUB & PMIC Operating Conditions

[Table 7] SPD HUB operating conditions

Parameter	Symbol	Min	Typ	Max	Units
Input Supply Voltage	VDDSPD	1.7	1.8	1.98	V
Input Supply Voltage	VDDIO	0.95	1	1.05	V
Case operating temperature	T _{CASE}	-40		125	°C
Case temperature range for NVM Write operation Data writes outside this range may not meet retention requirements.	T _{WRITEOK}	-40		95	°C

[Table 8] PMIC operating conditions

Parameter	Symbol	Min	Typ	Max	Units	note
Bulk Input Supply Voltage	VIN_Bulk	4.25	5	5.5	V	1)
Maximum Input Current for VIN_Bulk	IVIN_Bulk	0.05	-	2	A	2)

Note:

1. During first power on, the input voltage supply must reach minimum 4.25 V for PMIC to detect valid input supply.
2. The minimum input current requirement is to deliver the maximum output current on VOUT_1.8V and VOUT_1.0V LDO plus the current required by the PMIC for its own use. The maximum input current PMIC may see on its all VIN_Bulk input.

2.8 Environment Specifications

[Table 9] Operating Temperature condition

Symbol	Parameter	Rating	Unit	Note
T _{OPER}	DRAM Operating Temperature	-40 to 95	°C	1),2),3)
T _{STG}	Storage Temperature	-55 to 100	°C	4)

Note:

1. Operating temperature applies to the case temperature of all SDRAM components on the module. All other support components on the module must remain within their respective operating temperature ranges when the case temperature of the SDRAMs are at the minimum and maximum values. See JESD402-1 for details.
2. Operating Temperature is the case surface temperature on the center/top side of the DRAM. For the measurement conditions, please refer to JESD51-2 standard.
3. Average Refresh Period 3.9us at lower than Tcase 85°C , 1.95us at 85°C < Tcase ≤ 95°C. For more details, please refer to JESD79-5.
4. Storage temperature applies to the case temperature of all components on the module. See JESD402-1 for details. This is a stress rating only, and device functional operation at or above the conditions indicated is not implied. Exposure to absolute maximum ratings for extended periods may affect reliability.

2.9 System Reliability

[Table 10] Telcordia SR332 issue 4 MTBF Specifications

Parameter	TS2GSA64V8E-I
MTBF	> 1,500,000 hours

Note:

1. The calculation is based on 25°C.

[Table 11] Warranty

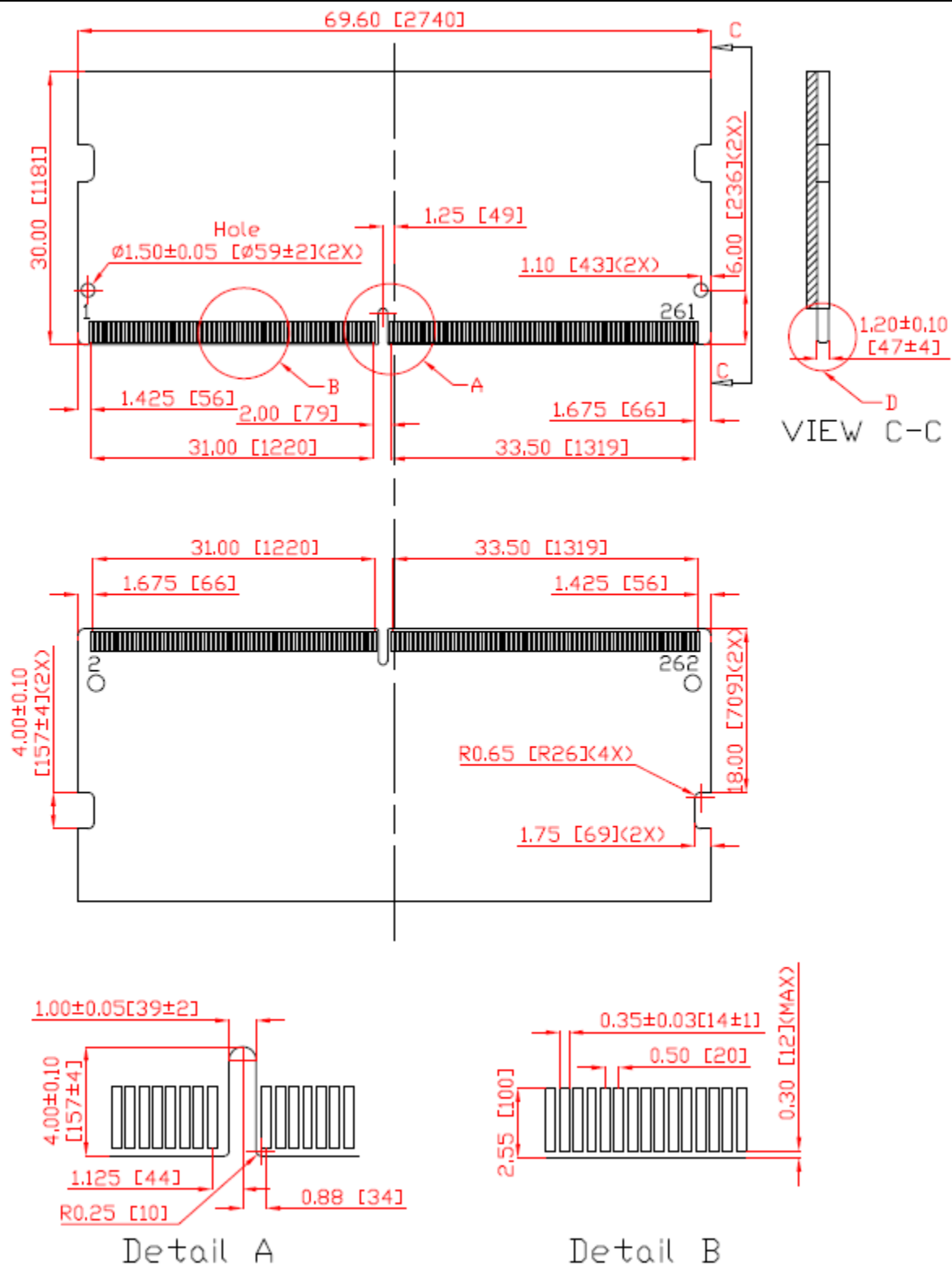
Parameter	TS2GSA64V8E-I
Warranty	Limited Lifetime Warranty

3. Mechanical Specification

The figure below illustrates the Transcend DDR5 wide-temperature SO DIMM.

[Table 12] Physical Dimensions and Weight

Model	Thickness (mm)	Width (mm)	Length (mm)
TS2GSA64V8E-I	Max 2.60	69.60	30.00



Note : All dimensions are in millimeters[mils] and should be kept within a tolerance of ± 0.15 [6], unless otherwise specified.

4. Pin Assignments

4.1 Pin Assignments

[Table 13] Pin Assignments

Pin#	Front Side	Pin#	Back Side
1	VIN_BULK	2	HSA
3	VIN_BULK	4	HSCL
5	RFU	6	HSDA
7	PWR_GOOD	8	PWR_EN
9	VSS	10	VSS
11	DQ0_A	12	DQ1_A
13	VSS	14	VSS
15	DQ2_A	16	DQ3_A
17	VSS	18	VSS
19	DM0_A_n	20	DQS0_A_c
21	VSS	22	DQS0_A_t
23	DQ4_A	24	VSS
25	VSS	26	DQ5_A
27	DQ6_A	28	VSS
29	VSS	30	DQ7_A
31	DQ8_A	32	VSS
33	VSS	34	DQ09_A
35	DQ10_A	36	VSS
37	VSS	38	DQ11_A
39	DQS1_A_c	40	VSS
41	DQS1_A_t	42	DM1_A_n
43	VSS	44	VSS
45	DQ12_A	46	DQ13_A
47	VSS	48	VSS
49	DQ14_A	50	DQ15_A
51	VSS	52	VSS
53	DQ16_A	54	DQ17_A
55	VSS	56	VSS
57	DQ18_A	58	DQ19_A
59	VSS	60	VSS
61	DM2_A_n	62	DQS2_A_c
63	VSS	64	DQS2_A_t
65	DQ20_A	66	VSS
Pin#	Front Side	Pin#	Back Side
67	VSS	68	DQ21_A

Pin#	Front Side	Pin#	Back Side
131	CK0_A_t	132	CK1_A_t
133	CK0_A_c	134	CK1_A_c
135	VSS	136	VSS
137	CK0_B_t	138	CK1_B_t
139	CK0_B_c	140	CK1_B_c
141	VSS	142	VSS
143	RFU	144	CA12_B
145	CA11_B	146	CA10_B
147	VSS	148	VSS
149	CA9_B	150	CA8_B
151	CA7_B	152	CA6_B
153	VSS	154	VSS
155	CA5_B	156	CA4_B
157	CA3_B	158	CA2_B
159	VSS	160	VSS
161	CS0_B_n	162	CA1_B
163	RESET_n	164	CA0_B
165	CS1_B_n	166	VSS
167	VSS	168	CB0_B
169	DQS4_B_c	170	VSS
171	DQS4_B_t	172	CB1_B
173	VSS	174	VSS
175	CB3_B	176	CB2_B
177	VSS	178	VSS
179	DQ0_B	180	DQ1_B
181	VSS	182	VSS
183	DQ2_B	184	DQ3_B
185	VSS	186	VSS
187	DM0_B_n	188	DQS0_B_c
189	VSS	190	DQS0_B_t
191	DQ4_B	192	VSS
193	VSS	194	DQ5_B
195	DQ6_B	196	VSS
Pin#	Front Side	Pin#	Back Side
197	VSS	198	DQ7_B

69	DQ22_A	70	VSS
71	VSS	72	DQ23_A
73	DQ24_A	74	VSS
75	VSS	76	DQ25_A
77	DQ26_A	78	VSS
79	VSS	80	DQ27_A
81	DQS3_A_c	82	VSS
83	DQS3_A_t	84	DM3_A_n
85	VSS	86	VSS
87	DQ28_A	88	DQ29_A
89	VSS	90	VSS
91	DQ30_A	92	DQ31_A
93	VSS	94	VSS
95	CB0_A	96	CB1_A
97	VSS	98	VSS
99	CB2_A	100	DQS4_A_c
101	VSS	102	DQS4_A_t
103	CB3_A	104	VSS
105	VSS	106	CS0_A_n
107	CA0_A	108	ALERT_n
109	CA1_A	110	CS1_A_n
111	VSS	112	VSS
113	CA2_A	114	CA3_A
115	CA4_A	116	CA5_A
117	VSS	118	VSS
119	CA6_A	120	CA7_A
121	CA8_A	122	CA9_A
123	VSS	124	VSS
125	CA10_A	126	CA11_A
KEY			
127	CA12_A	128	RFU
129	VSS	130	VSS

199	DQ8_B	200	VSS
201	VSS	202	DQ9_B
203	DQ10_B	204	VSS
205	VSS	206	DQ11_B
207	DQS1_B_c	208	VSS
209	DQS1_B_t	210	DM1_B_n
211	VSS	212	VSS
213	DQ12_B	214	DQ13_B
215	VSS	216	VSS
217	DQ14_B	218	DQ15_B
219	VSS	220	VSS
221	DQ16_B	222	DQ17_B
223	VSS	224	VSS
225	DQ18_B	226	DQ19_B
227	VSS	228	VSS
229	DM2_B_n	230	DQS2_B_c
231	VSS	232	DQS2_B_t
233	DQ20_B	234	VSS
235	VSS	236	DQ21_B
237	DQ22_B	238	VSS
239	VSS	240	DQ23_B
241	DQ24_B	242	VSS
243	VSS	244	DQ25_B
245	DQ26_B	246	VSS
247	VSS	248	DQ27_B
249	DQS3_B_c	250	VSS
251	DQS3_B_t	252	DM3_B_n
253	VSS	254	VSS
255	DQ28_B	256	DQ29_B
257	VSS	258	VSS
259	DQ30_B	260	DQ31_B
261	VSS	262	VSS

4.2 Pin Description

[Table 14] Pin Description

Symbol	Type	I/O Level	Function
CK0_A_t, CK0_A_c, CK1_A_t, CK1_A_c, CK0_B_t, CK0_B_c, CK1_B_t, CK1_B_c	Input	VDD	Clock: CK_t and CK_c are differential clock inputs. All address and control input signals are sampled on the crossing of the positive edge of CK_t and negative edge of CK_c.
CA0_A - CA12_A, CA0_B - CA12_B	Input	VDD	Command/Address Inputs: CA signals provide the command and address inputs according to the Command Truth Table. Note: Since some commands are multi cycle, the pins may not be interchanged between devices on the same bus.
CS0_A_n - CS1_A_n, CS0_B_n - CS1_B_n	Input	VDD	Chip Select: All commands are masked when CS_n is registered HIGH. CS_n provides for external Rank selection on systems with multiple Ranks.
DQ0_A - DQ31_A, DQ0_B - DQ31_B	Input/Output	VDDQ	Data Input/Output: Bi-directional data bus. If CRC is enabled via Mode register then CRC code is added at the end of Data Burst.
CB0_A - CB3_A, CB0_B - CB3_B	Input/Output	VDDQ	DIMM ECC check bits
DQS0_A_t - DQS4_A_t, DQS0_A_c - DQS4_A_c, DQS0_B_t - DQS4_B_t, DQS0_B_c - DQS4_B_c	Input/Output	VDDQ	Data Strobe: output with read data, input with write data. Edge-aligned with read data, centered in write data. DDR5 SDRAM supports differential data strobe only and does not support single-ended.
DM0_A_n - DM3_A_n, DM0_B_n - DM3_B_n	Input	VDDQ	Input Data Mask: DM_n is an input mask signal for write data. Input data is masked when DM_n is sampled LOW coincident with that input data during a Write access. DM_n is sampled on both edges of DQS. For x8 device, the function of DM_n is enabled by MR5:OP[5]=1.
ALERT_n	Input/Output	VDD	Alert: If there is error in CRC, then Alert_n goes LOW for the period time interval and goes back HIGH. During Connectivity Test mode, this pin works as input. Using this signal or not is dependent on system. In case of not connected as Signal, ALERT_n Pin must be bounded to VDDQ on board.
RESET_n	Input	VDD	Active Low Asynchronous Reset: Reset is active when RESET_n is LOW, and inactive when RESET_n is HIGH. RESET_n must be HIGH during normal operation. RESET_n is a CMOS rail to rail signal with DC

			high and low at 80% and 20% of VDDQ,
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Symbol	Type	I/O Level	Function
HSCL	Input	1.0V	Host SidebandBus bus clock, supplied by the controller.
HSDA	Input/Output	1.0V	Host SidebandBus data, connected from the controller to Hub or Host bus Target devices.
HSA	Input	2.1V max	Host SidebandBus bus device ID address pin; input to a Hub or other client device to distinguish between identical devices in the I3C-Basic/I2C address range.
RFU			Reserved for Future Use. No on DIMM electrical connection is present.
PWR_GOOD	Input/Output	Open Drain	Power good indicator. Open Drain output. The PMIC floats this pin high when VIN_Bulk input supply as well as all enabled output buck regulators and all LDO regulator tolerance threshold is maintained as configured in appropriate register. The PMIC drives this pin low when VIN_Bulk input goes below the threshold or when any of the enabled switch output regulators exceed the threshold configured in the appropriate register or any LDO output regulator exceeds the threshold tolerance. Input: The PMIC disables its output regulators when this pin is low. The LDO outputs shall remain on.
PWR_EN	Input	3.3V	PMIC Enable. When this pin is high, the PMIC turns on the regulator. When this pin is low, the PMIC turns off the regulator. This signal is connected to PMIC's VR_EN pin.
VIN_BULK	Supply	5V	5 V power input supply to the PMIC for analog circuits.
VSS	Supply		Ground

Pin Name	Description	Pin Name	Description
CA0_A – CA12_A, CA0_B – CA12_B	SDRAM Command/Address bus	HSCL	SidebandBus clock
CS0_A_n, CS1_A_n, CS0_B_n, CS1_B_n	SDRAM Chip Select	HSDA	SidebandBus data
DQ0_A – DQ31_A, DQ0_B – DQ31_B	DIMM memory data bus	HSA	SidebandBus address
CB0_A – CB3_A, CB0_B – CB3_B	DIMM ECC check bits	ALERT_n	SDRAM ALERT_n
DQS0_A_t – DQS4_A_t, DQS0_B_t – DQS4_B_t	SDRAM data strobes (positive line of differential pair)	RESET_n	Set DRAMs to a known State
DQS0_A_c – DQS4_A_c, DQS0_B_c – DQS4_B_c	SDRAM data strobes (negative line of differential pair)	VIN_BULK	5 V power input supply to the PMIC for analog circuits
DM0_A_n – DM3_A_n, DM0_B_n – DM3_B_n	SDRAM data masks	VSS	Power supply return (ground)
CK0_A_t, CK1_A_t, CK0_B_t, CK1_B_t	SDRAM clocks (positive line of differential pair)	PWR_GOOD	Power good indicator
CK0_A_c, CK1_A_c, CK0_B_c, CK1_B_c	SDRAM clocks (negative line of differential pair)	PWR_EN	PMIC Enable
RFU	Reserved for future use		

Note:

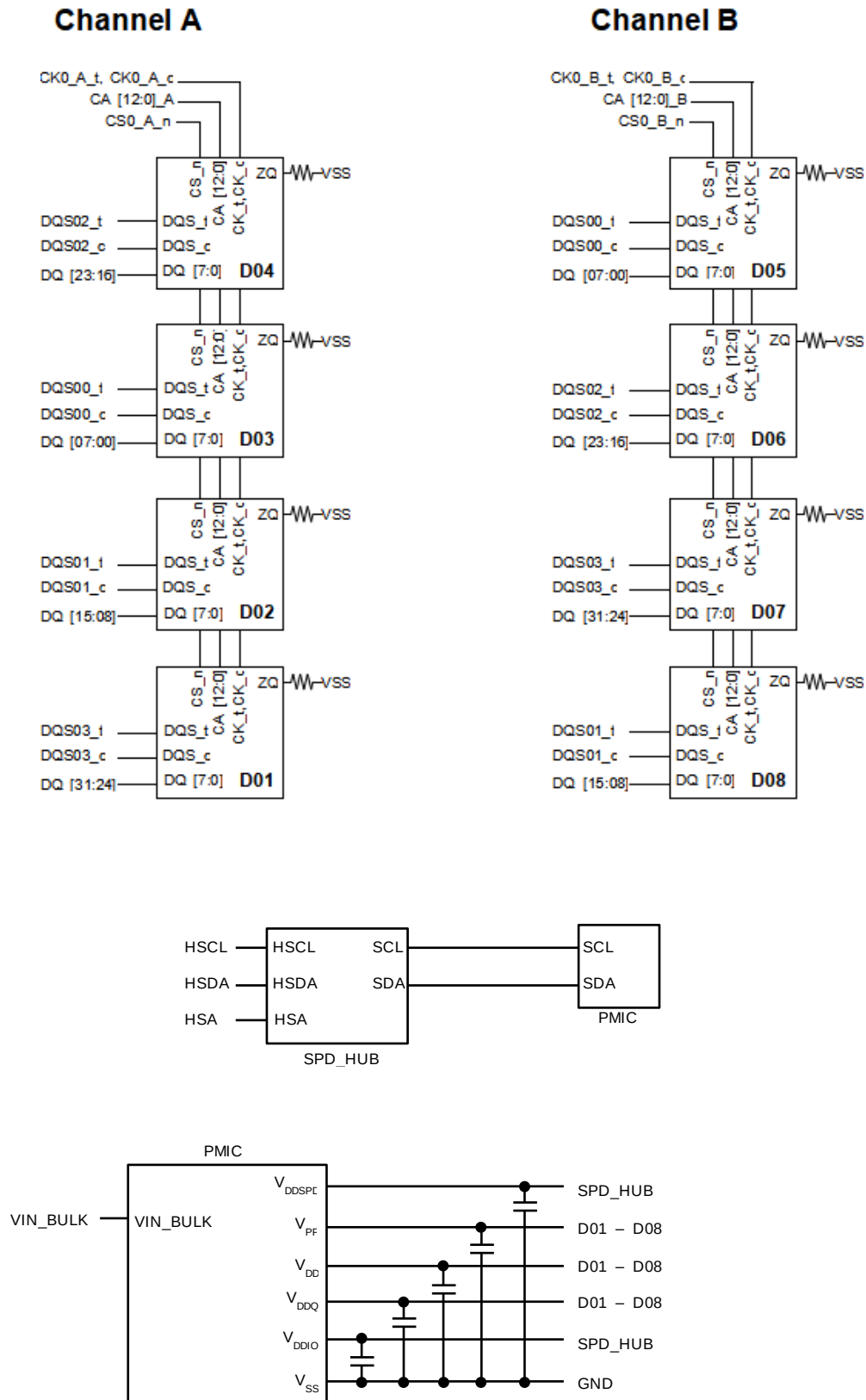
DDR5 SODIMM has 2 channels (channel-A and channel-B) of signal bus.

The signals with suffix: _A (e.g. DQ0_A) are for channel-A, and the signals with suffix: _B (e.g. DQ0_B) are for channel-B.

5. Block Diagram

5.1 Block Diagram

16GB, 2G x 64 Module (1 Rank x 8) TS2GSA64V8E-I



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